



# ACE2303B

## P-Channel Enhancement Mode Field Effect Transistor

### Description

This P-Channel enhancement mode power FETs are produced with high cell density, DMOS trench technology, which is especially used to minimize on-state resistance. This device is particularly suited for low voltage application such as portable equipment, power management and other battery powered circuits, and low in-line power loss are needed in a very small outline surface mount package.

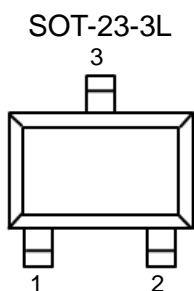
### Features

- $V_{DS} = -30V$
- $I_D = -3.6A$
- $R_{DS(ON)} = 58m\Omega @ V_{GS} = -10V$
- $R_{DS(ON)} = 87m\Omega @ V_{GS} = -4.5V$
- High density cell design for low  $R_{DS(ON)}$

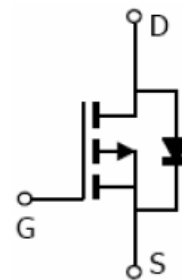
### Absolute Maximum Ratings

Parameter	Symbol	Max	Unit	
Drain-Source Voltage	$V_{DSS}$	-30	V	
Gate-Source Voltage	$V_{GSS}$	$\pm 20$	V	
Drain Current	Continuous	-3.6	A	
	Pulsed <sup>(1)</sup>	-10		
Power Dissipation	25°C	$P_D$	1.4	W
Operating and Storage Temperature Range		$T_J, T_{STG}$	-55 to 150	°C

### Packaging Type

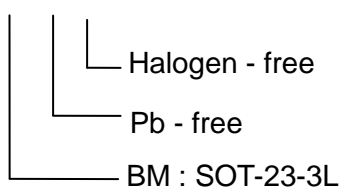


SOT-23-3L	Description
1	Gate
2	Source
3	Drain



### Ordering information

ACE2303B XX + H





### Electrical Characteristics

T<sub>A</sub>=25 °C unless otherwise noted

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Off characteristics						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	-30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V			-1	uA
Gate-Body Leakage, Forward	I <sub>GSSF</sub>	V <sub>GS</sub> =+20V, V <sub>DS</sub> =0V			100	nA
Gate-Body Leakage, Reverse	I <sub>GSSR</sub>	V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V			-100	nA
On characteristics <sup>(2)</sup>						
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3A		69	87	mΩ
		V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.1A		48	58	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA	-1	-1.6	-2.0	V
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =-5V, I <sub>D</sub> =-2.8A	4	6		S
Switching characteristics <sup>(3)</sup>						
Turn-On Delay Time	T <sub>d(on)</sub>	V <sub>DD</sub> =-6V, R <sub>L</sub> =6Ω I <sub>D</sub> =-1A, V <sub>GEN</sub> =-4.5V R <sub>G</sub> =6Ω			20	ns
Turn-On Rise Time	t <sub>r</sub>				10	
Turn-Off Delay Time	t <sub>d(off)</sub>				65	
Turn-Off Fall Time	t <sub>f</sub>				45	
Dynamic characteristics <sup>(3)</sup>						
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> =-6V, V <sub>GS</sub> =0V f=1.0MHz		680		pF
Output Capacitance	C <sub>OSS</sub>			72		
Feedback Capacitance	C <sub>RSS</sub>			58		
Drain-source diode characteristics and maximum ratings						
Drain-Source Diode Forward Current <sup>(4)</sup>	I <sub>S</sub>				-1.35	A
Drain-Source Diode Forward Voltage <sup>(2)</sup>	V <sub>SD</sub>	I <sub>S</sub> =-1A, V <sub>GS</sub> =0V	-0.6	-0.8	-1	V

Note: 1. Pulse width limited by maximum junction temperature

2. Pulse test: PW ≤ 300us, duty cycle ≤ 2%

3. Guaranteed by design, not subject to production testing.

4. Surface Mounted on FR4 Board, t < 5 sec.



Typical Performance Characteristics

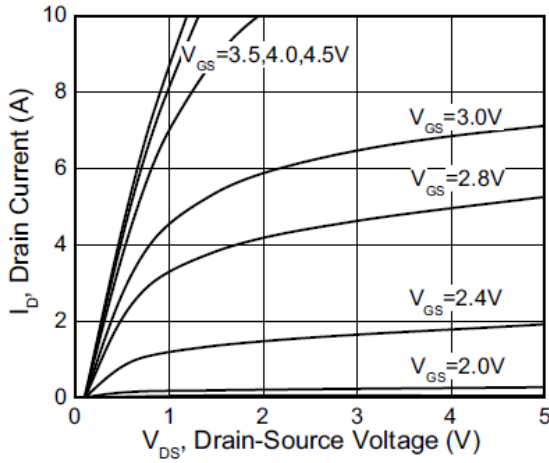


Figure 1. Output Characteristics

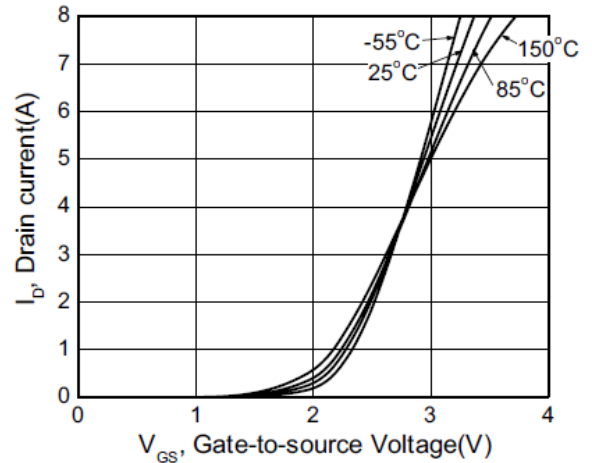


Figure 2. Transfer Characteristics

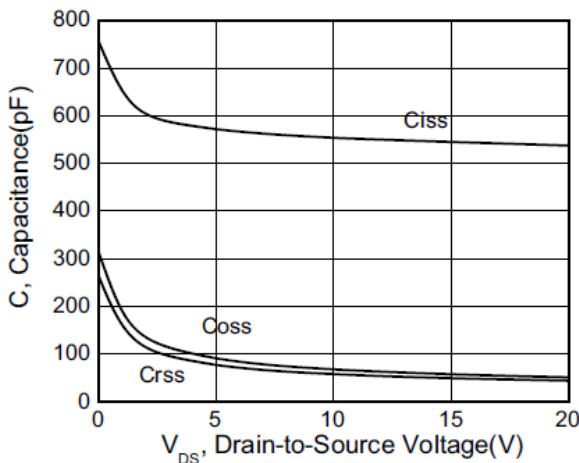


Figure 3. Capacitance

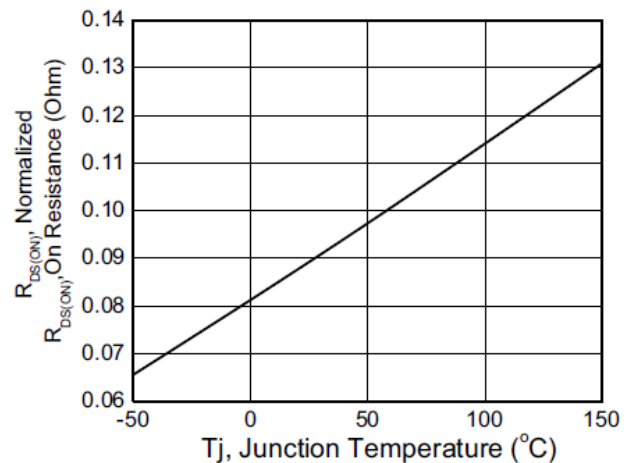


Figure 4. On Resistance Vs. Temperature

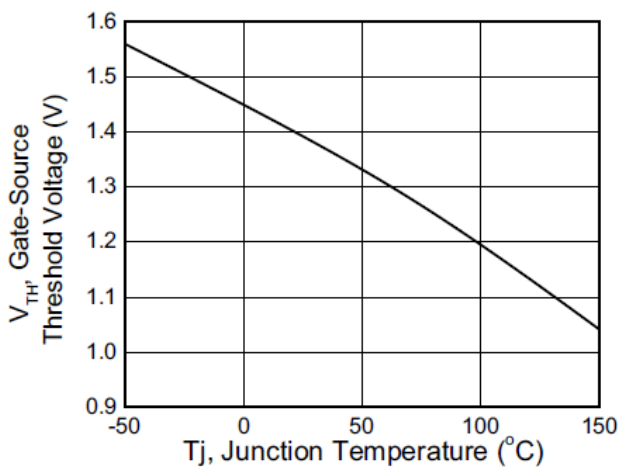


Figure 5. Gate Threshold Vs. Temperature

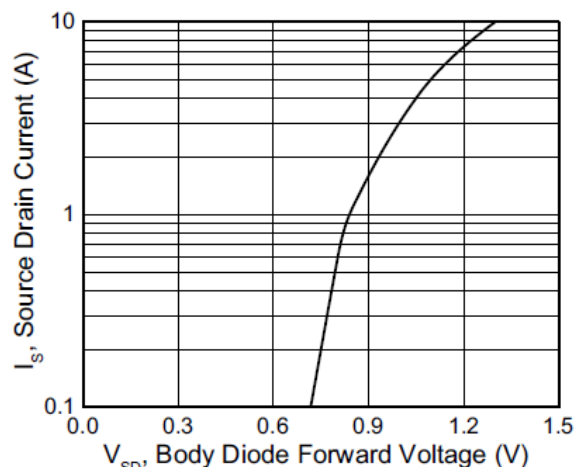


Figure 6. Body Diode Forward Voltage Vs. Source Current

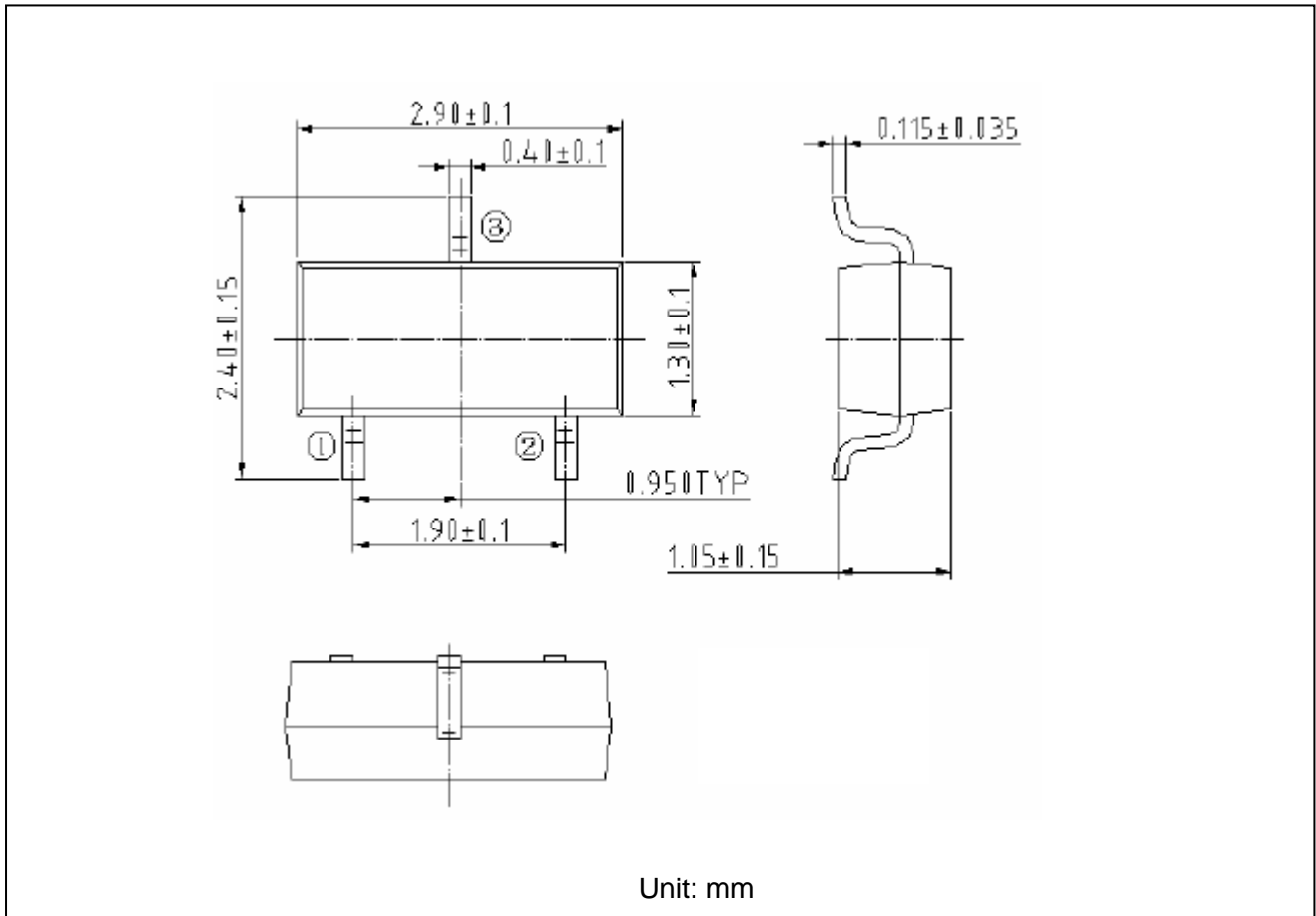


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### Packing Information

#### SOT-23-3L





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### Notes

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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